

## Environmental Protection Agency

## § 469.22

### SUBPART A—SEMICONDUCTOR NSPS EFFLUENT LIMITATIONS

Pollutant or pollutant property	Maximum for any 1 day	Average of daily values for 30 consecutive days
	Milligrams per liter (mg/l)	
TTO <sup>1</sup> .....	1.37	( <sup>2</sup> )
Fluoride (T) .....	32.0	17.4
pH .....	( <sup>2</sup> )	( <sup>3</sup> )

<sup>1</sup> Total toxic organics.

<sup>2</sup> Not applicable.

<sup>3</sup> Within the range of 6.0 to 9.0.

### § 469.18 Pretreatment standards for new sources (PSNS).

Except as provided in 40 CFR 403.7, any new source subject to this subpart which introduces pollutants into a publicly owned treatment works must comply with 40 CFR part 403 and achieve the following pretreatment standards for new sources (PSNS):

(a)

### SUBPART A—SEMICONDUCTOR PSNS EFFLUENT LIMITATIONS

Pollutant or pollutant property	Maximum for any 1 day	Average of daily values for 30 consecutive days
	Milligrams per liter (mg/l)	
TTO <sup>1</sup> .....	1.37	( <sup>2</sup> )

<sup>1</sup> Total toxic organics.

<sup>2</sup> Not applicable.

(b) A new source submitting a certification in lieu of monitoring pursuant to § 469.13 (c) and (d) of this regulation must implement the solvent management plan approved by the control authority.

### § 469.19 Effluent limitations representing the degree of effluent reduction attainable by the application of the best conventional pollution control technology (BCT).

Except as provided in 40 CFR 125.30 through 125.32, any existing point source subject to this subpart must achieve the following effluent limitations representing the degree of effluent reduction attainable by the application of the best conventional pollution control technology (BCT):

### SUBPART A—SEMICONDUCTOR BCT EFFLUENT LIMITATIONS

Pollutant or pollutant property	Maximum for any 1 day	Average of daily values for 30 consecutive days
pH .....	( <sup>1</sup> )	( <sup>1</sup> )

<sup>1</sup> Within the range 6.0 to 9.0.

### Subpart B—Electronic Crystals Subcategory

#### § 469.20 Applicability.

(a) The provisions of this subpart are applicable to discharges resulting from the manufacture of electronic crystals.

(b) [Reserved]

#### § 469.21 Compliance dates.

The compliance date for the BAT fluoride limitation is as soon as possible as determined by the permit writer but in no event later than November 8, 1985. The compliance date for PSES for total toxic organics (TTO) is July 1, 1984 and for arsenic is November 8, 1985.

[48 FR 45250, Oct. 4, 1983, as amended at 49 FR 5923, Feb. 16, 1984]

#### § 469.22 Specialized definitions.

The definitions in 40 CFR part 401 and the chemical analysis methods in 40 CFR part 136 apply to this subpart. In addition,

(a) The term “total toxic organics (TTO)” means the sum of the concentrations for each of the following toxic organic compounds which is found in the discharge at a concentration greater than ten (10) micrograms per liter:

1,2,4 Trichlorobenzene chloroform  
 1,2 Dichlorobenzene  
 1,3, Dichlorobenzene  
 1,4, Dichlorobenzene ethylbenzene  
 1,1,1 Trichloroethane methylene chloride  
 naphthalene  
 2 Nitrophenol phenol bis (2-ethylhexyl)  
 phthalate tetrachloroethylene toluene tri-  
 chloroethylene  
 2 Chlorophenol  
 2,4 Dichlorophenol  
 4 Nitrophenol pentachlorophenol di-n-butyl  
 phthalate anthracene  
 1,2 Diphenylhydrazine isophorone butyl ben-  
 zyl pthalate  
 1,1 Dichloroethylene  
 2,4,6 Trichlorophenol carbon tetrachloride  
 1,2 Dichloroethane